Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/658,158	TRAN ET AL.
Examiner	Art Unit
Tan T. Nguyen	2827

SEARCHED					
Class	Subclass	Date	Examiner		
365	173	3/30/2005	TNT		
365	171	3/30/2005	TNT		
365	157	3/30/2005	TNT		
365	158	3/30/2005	TNT		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
365	157	3/30/2005	TNT	
365	158	3/30/2005	TNT	
365	171	3/30/2005	TNŢ	
365/	/173	3/30/2005	TNT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
		 	
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